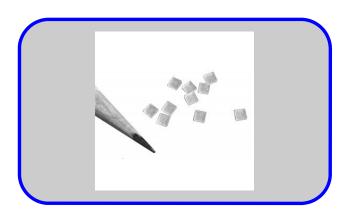
TLD 100-H High Sensitivity LiF Detectors

TLD-100H material is approximately fifteen times more sensitive than standard LiF TLD-100 and due to its improved energy response it is ideal for low dose assessment work for low energy radiation and does not suffer from Supralinearlity



| SPECIFICATIONS: TLD-100H | |
|---|---------------|
| Square Chips dimensions are: 1/8" x 1/8" x 0.035" (3.2 mm x 3.2 mm x 0.89 mm) | |
| Sensitivity at 662 keV relative to LiF:Mg,Ti, times/unit mass in solid form | >15 |
| Sensitivity to thermal neutrons, Relative to TLD-700 | ×13 ≈1 |
| TL emission spectrum (max), nm | ≈400 |
| Temperature of main glow peak, °C | ≈230 |
| Fading per year, with recommended preheat | Negligible |
| Useful dose range | 1μGy-10Gy |
| Background, μGy | <1 |
| Effective atomic number | ≈8.2 |
| Energy response (photons) 30keV/662 keV | ≈1.06 |
| Light induced fading at 150 lux for 1 min, % of signal | <.05 |
| Reproducibility at 1 cGy, % | <u><</u> 3 |
| Standard response is +/- 15% (+/- 2 sigma) for these sizes per batch unless otherwise noted | <u><</u> 8 |
| Re-use at low dose with less than 10% loss in sensitivity, times | 50 |
| Residual after total dose above 1 cGy; % of signal | <.1% |
| Recommended oven anneal cycle, after total dose above 1 cGy | |
| remperature, ° | 240 |
| Time, min | 10- 40 |
| Recommended Reader Readout Cycle: | |
| Preheat temperature, °C | 150 |
| Preheat time, sec | 10-15 |
| Heating rate, °C/sec | 25 |
| Maximum temperature | 240-260 |
| Readout time sec | 10-15 |
| Anneal temperature, °C if required | 240-260 |
| Anneal time, sec | 20 |
| Residual subsequent to a second re-read | |



Readers



Recommend 240 ° max for Manual Plonchet Readers and up to 260 ° for Hot Gas



